# **Small Signal MOSFET**

60 V, 115 mA, N-Channel SOT-23

#### **Features**

- 2V Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Qualified and PPAP Capable (2V7002L)
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

### **MAXIMUM RATINGS**

Rating	Symbol	Value	Unit
Drain-Source Voltage	V <sub>DSS</sub>	60	Vdc
Drain–Gate Voltage ( $R_{GS} = 1.0 \text{ M}\Omega$ )	V <sub>DGR</sub>	60	Vdc
Drain Current  - Continuous $T_C = 25^{\circ}C$ (Note 1) $T_C = 100^{\circ}C$ (Note 1)  - Pulsed (Note 2)	I <sub>D</sub> I <sub>D</sub>	±115 ±75 ±800	mAdc
Gate-Source Voltage - Continuous - Non-repetitive (t <sub>p</sub> ≤ 50 μs)	V <sub>GS</sub> V <sub>GSM</sub>	±20 ±40	Vdc Vpk

### THERMAL CHARACTERISTICS

Characteristic	Symbol	Max	Unit
Total Device Dissipation FR-5 Board (Note 3) T <sub>A</sub> = 25°C Derate above 25°C Thermal Resistance, Junction-to-Ambient	P <sub>D</sub>	225 1.8 556	mW mW/°C °C/W
Total Device Dissipation (Note 4) Alumina Substrate, T <sub>A</sub> = 25°C Derate above 25°C Thermal Resistance, Junction–to–Ambient	P <sub>D</sub>	300 2.4 417	mW mW/°C °C/W
Junction and Storage Temperature	T <sub>J</sub> , T <sub>stg</sub>	-55 to +150	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

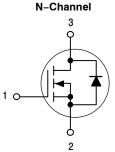
- The Power Dissipation of the package may result in a lower continuous drain current.
- 2. Pulse Test: Pulse Width ≤ 300 µs, Duty Cycle ≤ 2.0%.
- 3.  $FR-5 = 1.0 \times 0.75 \times 0.062$  in.
- 4. Alumina = 0.4 x 0.3 x 0.025 in 99.5% alumina.

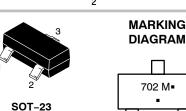


### ON Semiconductor®

### http://onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> MAX	I <sub>D</sub> MAX
60 V	7.5 Ω @ 10 V, 500 mA	115 mA





SOT-23 CASE 318 STYLE 21

> 702 = Device Code M = Date Code\*

= Pb-Free Package

(Note: Microdot may be in either location)
\*Date Code orientation and/or position may vary depending upon manufacturing location.

### ORDERING INFORMATION

Device	Package	Shipping <sup>†</sup>	
2N7002LT1G	SOT-23	3000 Tape & Reel	
2N7002LT3G	(Pb-Free)	10,000 Tape & Reel	
2V7002LT1G		3000 Tape & Reel	
2V7002LT3G	SOT-23	10,000 Tape & Reel	
2N7002LT1H*	(Pb-Free)	3000 Tape & Reel	

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

<sup>\*</sup>Not for new design.

# **ELECTRICAL CHARACTERISTICS** ( $T_A = 25^{\circ}C$ unless otherwise noted)

Characteristic	Symbol	Min	Тур	Max	Unit		
OFF CHARACTERISTICS							
Drain-Source Breakdown Voltage ( $V_{GS} = 0$ , $I_D = 10 \mu Adc$ )	V <sub>(BR)DSS</sub>	60	-	-	Vdc		
Zero Gate Voltage Drain Current $T_J = 25^{\circ}C$ $(V_{GS} = 0, V_{DS} = 60 \text{ Vdc})$ $T_J = 125^{\circ}C$		-		1.0 500	μAdc		
Gate-Body Leakage Current, Forward (V <sub>GS</sub> = 20 Vdc)	I <sub>GSSF</sub>	_	-	100	nAdc		
Gate-Body Leakage Current, Reverse (V <sub>GS</sub> = -20 Vdc)	I <sub>GSSR</sub>	-	-	-100	nAdc		
ON CHARACTERISTICS (Note 5)							
Gate Threshold Voltage (V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250 μAdc)	V <sub>GS(th)</sub>	1.0	-	2.5	Vdc		
On–State Drain Current $(V_{DS} \ge 2.0 V_{DS(on)}, V_{GS} = 10 \text{ Vdc})$	I <sub>D(on)</sub>	500	-	_	mA		
Static Drain–Source On–State Voltage $(V_{GS} = 10 \text{ Vdc}, I_D = 500 \text{ mAdc})$ $(V_{GS} = 5.0 \text{ Vdc}, I_D = 50 \text{ mAdc})$	V <sub>DS(on)</sub>	- -	- -	3.75 0.375	Vdc		
$ \begin{array}{llllllllllllllllllllllllllllllllllll$	;	- - -	- - - -	7.5 13.5 7.5 13.5	Ohms		
Forward Transconductance ( $V_{DS} \ge 2.0 V_{DS(on)}$ , $I_D = 200 \text{ mAdc}$ )	9 <sub>FS</sub>	80	-	_	mS		
DYNAMIC CHARACTERISTICS	Į.		I		1		
Input Capacitance (V <sub>DS</sub> = 25 Vdc, V <sub>GS</sub> = 0, f = 1.0 MHz)	C <sub>iss</sub>	-	_	50	pF		
Output Capacitance (V <sub>DS</sub> = 25 Vdc, V <sub>GS</sub> = 0, f = 1.0 MHz)	C <sub>oss</sub>	-	-	25	pF		
Reverse Transfer Capacitance (V <sub>DS</sub> = 25 Vdc, V <sub>GS</sub> = 0, f = 1.0 MHz)	C <sub>rss</sub>	-	-	5.0	pF		
SWITCHING CHARACTERISTICS (Note 5)	<u>'</u>		1	•	•		
Turn–On Delay Time $(V_{DD} = 25 \text{ Vdc}, I_D \approx 500 \text{ mAdc},$	t <sub>d(on)</sub>	-	-	20	ns		
Turn–Off Delay Time $R_G = 25 \Omega$ , $R_L = 50 \Omega$ , $V_{gen} = 10 V$ )	t <sub>d(off)</sub>	-	-	40	ns		
BODY-DRAIN DIODE RATINGS							
Diode Forward On-Voltage (I <sub>S</sub> = 11.5 mAdc, V <sub>GS</sub> = 0 V)	V <sub>SD</sub>	_	-	-1.5	Vdc		
Source Current Continuous (Body Diode)	I <sub>S</sub>	_	-	-115	mAdc		
Source Current Pulsed	I <sub>SM</sub>	-	-	-800	mAdc		
	•						

<sup>5.</sup> Pulse Test: Pulse Width  $\leq$  300  $\mu$ s, Duty Cycle  $\leq$  2.0%.

## TYPICAL ELECTRICAL CHARACTERISTICS

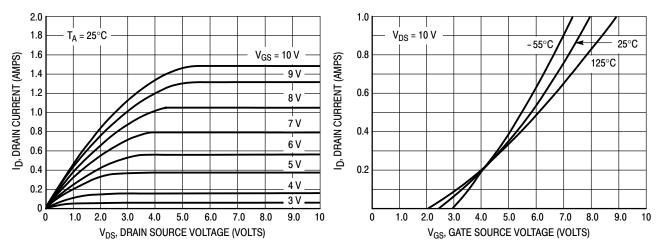


Figure 1. Ohmic Region

Figure 2. Transfer Characteristics

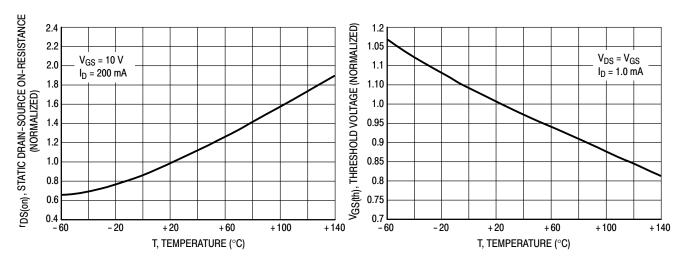
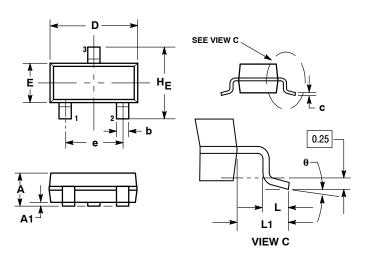


Figure 3. Temperature versus Static Drain-Source On-Resistance

Figure 4. Temperature versus Gate
Threshold Voltage

### PACKAGE DIMENSIONS

### SOT-23 (TO-236) CASE 318-08 **ISSUE AP**



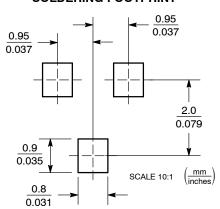
#### NOTES

- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
- CONTROLLING DIMENSION: INCH.
- MAXIMUM LEAD THICKNESS INCLUDES LEAD FINISH THICKNESS. MINIMUM LEAD THICKNESS IS THE MINIMUM THICKNESS OF BASE MATERIAL.
- DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS.

		MILLIMETERS			INCHES		
D	MIC	MIN	NOM	MAX	MIN	NOM	MAX
	Α	0.89	1.00	1.11	0.035	0.040	0.044
-	41	0.01	0.06	0.10	0.001	0.002	0.004
	b	0.37	0.44	0.50	0.015	0.018	0.020
	С	0.09	0.13	0.18	0.003	0.005	0.007
	D	2.80	2.90	3.04	0.110	0.114	0.120
	E	1.20	1.30	1.40	0.047	0.051	0.055
	е	1.78	1.90	2.04	0.070	0.075	0.081
	L	0.10	0.20	0.30	0.004	0.008	0.012
	L1	0.35	0.54	0.69	0.014	0.021	0.029
H	ΗE	2.10	2.40	2.64	0.083	0.094	0.104
	θ	0°		10°	0°		10°

#### STYLE 21:

- PIN 1. GATE
  - 2. 3. SOURCE DRAIN
- **SOLDERING FOOTPRINT**



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